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Details

Product Status	Active
Core Processor	HC08
Core Size	8-Bit
Speed	8MHz
Connectivity	SCI, SPI
Peripherals	LVD, POR, PWM
Number of I/O	24
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	512 x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 10x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	28-TSSOP (0.173", 4.40mm Width)
Supplier Device Package	28-TSSOP
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mc908qc16vdre

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Revision History

The following revision history table summarizes changes contained in this document. For your convenience, the page number designators have been linked to the appropriate location.

Revision History

Date	Revision Level	Description	Page Number(s)
April, 2006	1.0	Initial release	N/A
		19.5 5-V DC Electrical Characteristics — Updated values	237
		19.8 3.3-V DC Electrical Characteristics — Updated values	240
May, 2006	1.1	19.11 Oscillator Characteristics — Updated values	243
		Figure 19-9. Typical 5-Volt Run Current versus Bus Frequency (25 C) and Figure 19-10. Typical 3.3-Volt Run Current versus Bus Frequency (25 C) — added	247
		1.7 Unused Pin Termination — Added new section	24
		11.2 Unused Pin Termination — Replaced note with new section	107
		19.5 5-V DC Electrical Characteristics — New values for: DC injection current Low-voltage inhibit reset, trip rising voltage	237
October, 2006	2.0	19.8 3.3-V DC Electrical Characteristics — New values for: DC injection current Low-voltage inhibit reset, trip rising voltage	240
		19.12 Supply Current Characteristics — New values for stop mode supply currents at –40 to 125° C	246
		20.3 Package Dimensions — Updated package dimension drawing for the 28-lead TSSOP.	261
		Table 1-2. Pin Functions — Added note	22
		Figure 2-2. Control, Status, and Data Registers — Corrected Port C Data Register bit PTC3	27
		Chapter 3 Analog-to-Digital Converter (ADC10) Module — Renamed ADCSC register to ADSCR to be consistent with development tools	45
		Chapter 4 Configuration Registers (CONFIG1 and CONFIG2) — Changed CGMXCLK to BUSCLKX4	60
		11.3 Port A — Added information to first paragraph of note	107
April, 2007	3.0	11.3.1 Port A Data Register — Corrected bit designations for the first entry under Figure 11-1. Port A Data Register (PTA).	108
		11.5 Port C — Added note and corrected address location designation in last paragraph	112 113
		Chapter 13 Enhanced Serial Communications Interface (ESCI) Module — Changed SCIBDSRC to ESCIBDSRC and CGMXCLK to BUSCLKX4	123
		13.9.3 Bit Time Measurement — Corrected first sentence of listing number 1	150
		Figure 18-18. Monitor Mode Entry Timing — Changed CGMXCLK to BUSCLKX4	234
October, 2007	4.0	In 19.12 Supply Current Characteristics, updated stop I _{DD} values	246
April, 2008	5.0	In 19.12 Supply Current Characteristics, reverted to Rev. 3 stop I_{DD} values	246



Chapter 2 Memory

2.1 Introduction

The central processor unit (CPU08) can address 64 Kbytes of memory space. The memory map is shown in Figure 2-1.

2.2 Unimplemented Memory Locations

Executing code from an unimplemented location will cause an illegal address reset. In Figure 2-1, unimplemented locations are shaded.

2.3 Reserved Memory Locations

Accessing a reserved location can have unpredictable effects on MCU operation. In Figure 2-1, reserved locations are marked with the word reserved or with the letter R.

2.4 Direct Page Registers

Figure 2-2 shows the memory mapped registers. Registers with addresses between \$0000 and \$00FF are considered direct page registers and all instructions including those with direct page addressing modes can access them. Registers between \$0100 and \$FFFF require non-direct page addressing modes. See Chapter 6 Central Processor Unit (CPU) for more information on addressing modes.



Central Processor Unit (CPU)

6.3.5 Condition Code Register

The 8-bit condition code register contains the interrupt mask and five flags that indicate the results of the instruction just executed. Bits 6 and 5 are set permanently to 1. The following paragraphs describe the functions of the condition code register.



Figure 6-6. Condition Code Register (CCR)

V — Overflow Flag

The CPU sets the overflow flag when a two's complement overflow occurs. The signed branch instructions BGT, BGE, BLE, and BLT use the overflow flag.

- 1 = Overflow
- 0 = No overflow

H — Half-Carry Flag

The CPU sets the half-carry flag when a carry occurs between accumulator bits 3 and 4 during an add-without-carry (ADD) or add-with-carry (ADC) operation. The half-carry flag is required for binary-coded decimal (BCD) arithmetic operations. The DAA instruction uses the states of the H and C flags to determine the appropriate correction factor.

1 = Carry between bits 3 and 4

0 = No carry between bits 3 and 4

I — Interrupt Mask

When the interrupt mask is set, all maskable CPU interrupts are disabled. CPU interrupts are enabled when the interrupt mask is cleared. When a CPU interrupt occurs, the interrupt mask is set automatically after the CPU registers are saved on the stack, but before the interrupt vector is fetched.

- 1 = Interrupts disabled
- 0 = Interrupts enabled

NOTE

To maintain M6805 Family compatibility, the upper byte of the index register (H) is not stacked automatically. If the interrupt service routine modifies H, then the user must stack and unstack H using the PSHH and PULH instructions.

After the I bit is cleared, the highest-priority interrupt request is serviced first. A return-from-interrupt (RTI) instruction pulls the CPU registers from the stack and restores the interrupt mask from the stack. After any reset, the interrupt mask is set and can be cleared only by the clear interrupt mask software instruction (CLI).

N — Negative Flag

The CPU sets the negative flag when an arithmetic operation, logic operation, or data manipulation produces a negative result, setting bit 7 of the result.

1 = Negative result

0 = Non-negative result



Source		Description			Effect on CCR				ess e ode		and	Se
Form	Operation	Description	v	н	I	Ν	z	С	Addr	Opco	Oper	Cycle
JMP opr JMP opr JMP opr,X JMP opr,X JMP ,X	Jump	$PC \gets Jump \; Address$	_	_	_	_	_	_	DIR EXT IX2 IX1 IX	BC CC DC EC FC	dd hh II ee ff ff	2 3 4 3 2
JSR opr JSR opr JSR opr,X JSR opr,X JSR ,X	Jump to Subroutine	$\begin{array}{l} PC \leftarrow (PC) + n \ (n = 1, 2, \mathrm{or} \ 3) \\ Push \ (PCL); \ SP \leftarrow (SP) - 1 \\ Push \ (PCH); \ SP \leftarrow (SP) - 1 \\ PC \leftarrow Unconditional \ Address \end{array}$	_	-	_	_	_	_	DIR EXT IX2 IX1 IX	BD CD DD ED FD	dd hh ll ee ff ff	4 5 6 5 4
LDA #opr LDA opr LDA opr,X LDA opr,X LDA opr,X LDA ,X LDA opr,SP LDA opr,SP	Load A from M	A ← (M)	0	_	_	\$	\$	_	IMM DIR EXT IX2 IX1 IX SP1 SP2	A6 B6 C6 D6 E6 F6 9EE6 9ED6	ii dd hh II ee ff ff ee ff	23443245
LDHX # <i>opr</i> LDHX <i>opr</i>	Load H:X from M	$H{:}X \gets (M{:}M+1)$	0	-	-	¢	\$	-	IMM DIR	45 55	ii jj dd	3 4
LDX #opr LDX opr LDX opr LDX opr,X LDX opr,X LDX opr,SP LDX opr,SP	Load X from M	X ← (M)	0	_	_	\$	\$	_	IMM DIR EXT IX2 IX1 IX SP1 SP2	AE BE CE DE EE FE 9EEE 9EDE	ii dd hh II ee ff ff ff ee ff	23443245
LSL opr LSLA LSLX LSL opr,X LSL ,X LSL ,A LSL opr,SP	Logical Shift Left (Same as ASL)	C - 0 b7 b0	\$	_	_	\$	\$	\$	DIR INH INH IX1 IX SP1	38 48 58 68 78 9E68	dd ff ff	4 1 4 3 5
LSR opr LSRA LSRX LSR opr,X LSR ,X LSR ,Opr,SP	Logical Shift Right	$0 \rightarrow \boxed{\begin{array}{c} & & \\ & & \\ & & \\ & & \\ & b7 & b0 \end{array}} \rightarrow \boxed{C}$	¢	-	_	0	\$	¢	DIR INH INH IX1 IX SP1	34 44 54 64 74 9E64	dd ff ff	4 1 4 3 5
MOV opr,opr MOV opr,X+ MOV #opr,opr MOV X+,opr	Move	$\begin{array}{l} (M)_{Destination} \leftarrow (M)_{Source} \\ H:X \leftarrow (H:X) + 1 \; (IX+D, DIX+) \end{array}$	0	_	_	\$	\$	_	DD DIX+ IMD IX+D	4E 5E 6E 7E	dd dd dd ii dd dd	5 4 4 4
MUL	Unsigned multiply	$X:A \gets (X) \times (A)$	-	0	-	-	-	0	INH	42		5
NEG opr NEGA NEGX NEG opr,X NEG ,X NEG opr,SP	Negate (Two's Complement)	$\begin{array}{l} M \leftarrow -(M) = \$00 - (M) \\ A \leftarrow -(A) = \$00 - (A) \\ X \leftarrow -(X) = \$00 - (X) \\ M \leftarrow -(M) = \$00 - (M) \\ M \leftarrow -(M) = \$00 - (M) \end{array}$	¢	1	_	\$	\$	\$	DIR INH IX1 IX SP1	30 40 50 60 70 9E60	dd ff ff	4 1 4 3 5
NOP	No Operation	None	-	-	_	-	-	-	INH	9D		1
NSA ODA #	Nibble Swap A	A ← (A[3:0]:A[7:4])	-	-	-	-	-	-	INH	62		3
ORA #opr ORA opr ORA opr ORA opr,X ORA opr,X ORA ,X ORA opr,SP ORA opr,SP	Inclusive OR A and M	$A \gets (A) \mid (M)$	0	_	_	\$	\$	_	IMM DIR EXT IX2 IX1 IX SP1 SP2	AA BA CA DA EA FA 9EEA 9EDA	ii dd hh II ee ff ff ee ff	23443245
PSHA	Push A onto Stack	Push (A); SP \leftarrow (SP) – 1	-	-	-	-	-	-	INH	87		2
PSHH PSHX	Push H onto Stack	Push (H); SP \leftarrow (SP) – 1 Push (X); SP \leftarrow (SP) – 1	-	-	-	-	-	-	INH	8B 89		2
		$(\Lambda), SF \leftarrow (SF) = I$	L	-	1		1	-		09		2

Table 6-1. Instruction Set Summary	y	(Sheet 4 of 6))
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External Interrupt (IRQ)

7.3.2 MODE = 0

If the MODE bit is clear, the IRQ pin is falling edge sensitive only. With MODE clear, an IRQ vector fetch or software clear immediately clears the IRQ latch.

The IRQF bit in INTSCR can be read to check for pending interrupts. The IRQF bit is not affected by IMASK, which makes it useful in applications where polling is preferred.

NOTE

When using the level-sensitive interrupt trigger, avoid false IRQ interrupts by masking interrupt requests in the interrupt routine.

7.4 Interrupts

The following IRQ source can generate interrupt requests:

 Interrupt flag (IRQF) — The IRQF bit is set when the IRQ pin is asserted based on the IRQ mode. The IRQ interrupt mask bit, IMASK, is used to enable or disable IRQ interrupt requests.

7.5 Low-Power Modes

The WAIT and STOP instructions put the MCU in low power-consumption standby modes.

7.5.1 Wait Mode

The IRQ module remains active in wait mode. Clearing IMASK in INTSCR enables IRQ interrupt requests to bring the MCU out of wait mode.

7.5.2 Stop Mode

The IRQ module remains active in stop mode. Clearing IMASK in INTSCR enables IRQ interrupt requests to bring the MCU out of stop mode.

7.6 IRQ Module During Break Interrupts

The system integration module (SIM) controls whether status bits in other modules can be cleared during the break state. The BCFE bit in the break flag control register (BFCR) enables software to clear status bits during the break state. See BFCR in the SIM section of this data sheet.

To allow software to clear status bits during a break interrupt, write a 1 to BCFE. If a status bit is cleared during the break state, it remains cleared when the MCU exits the break state.

To protect status bits during the break state, write a 0 to BCFE. With BCFE cleared (its default state), software can read and write registers during the break state without affecting status bits. Some status bits have a two-step read/write clearing procedure. If software does the first step on such a bit before the break, the bit cannot change during the break state as long as BCFE is cleared. After the break, doing the second step clears the status bit.



External Interrupt (IRQ)

Keyboard Interrupt Module (KBI)



All port pins can be configured with internal pullup PTC not available on 16-pin devices (see note in 11.1 Introduction) PTD not available on 16-pin or 20-pin devices (see note in 11.1 Introduction)

Figure 8-2. Block Diagram Highlighting KBI Block and Pins



Keyboard Interrupt Module (KBI)



Low-Voltage Inhibit (LVI)



10.3.1.2 XTAL Oscillator Clock (XTALCLK)

XTALCLK is the XTAL oscillator output signal. It runs at the full speed of the crystal (f_{XCLK}) and comes directly from the crystal oscillator circuit. Figure 10-2 shows only the logical relation of XTALCLK to OSC1 and OSC2 and may not represent the actual circuitry. The duty cycle of XTALCLK is unknown and may depend on the crystal and other external factors. The frequency of XTALCLK can be unstable at start up.

10.3.1.3 RC Oscillator Clock (RCCLK)

RCCLK is the RC oscillator output signal. Its frequency is directly proportional to the time constant of the external R (R_{EXT}) and internal C. Figure 10-3 shows only the logical relation of RCCLK to OSC1 and may not represent the actual circuitry.

10.3.1.4 Internal Oscillator Clock (INTCLK)

INTCLK is the internal oscillator output signal. INTCLK is software selectable to be nominally 25.6 MHz, 12.8 MHz, 8.0 MHz, or 4.0 MHz. INTCLK can be digitally adjusted using the oscillator trimming feature of the OSCTRIM register (see 10.3.2.1 Internal Oscillator Trimming).

10.3.1.5 Bus Clock Times 4 (BUSCLKX4)

BUSCLKX4 is the same frequency as the input clock (XTALCLK, RCCLK, or INTCLK). This signal is driven to the SIM module and is used during recovery from reset and stop and is the clock source for the COP module.

10.3.1.6 Bus Clock Times 2 (BUSCLKX2)

The frequency of this signal is equal to half of the BUSCLKX4. This signal is driven to the SIM for generation of the bus clocks used by the CPU and other modules on the MCU. BUSCLKX2 will be divided by two in the SIM. The internal bus frequency is one fourth of the XTALCLK, RCCLK, or INTCLK frequency.

10.3.2 Internal Oscillator

The internal oscillator circuit is designed for use with no external components to provide a clock source with a tolerance of less than 25%untrimmed. An 8-bit register (OSCTRIM) allows the digital adjustment to a tolerance of ACC_{INT}. See the oscillator characteristics in the Electrical section of this data sheet.

The internal oscillator is capable of generating clocks of 25.6 MHz, 12.8 MHz, 8.0 MHz, or 4.0 MHz (INTCLK) resulting in a bus frequency (INTCLK divided by 4) of 6.4 MHz, 3.2 MHz, 2.0 MHz, or 1.0 MHz respectively. The bus clock is software selectable and defaults to the 1.0-MHz bus out of reset. Users can increase the bus frequency based on the voltage range of their application.

Figure 10-3 shows how BUSCLKX4 is derived from INTCLK and OSC2 can output BUSCLKX4 by setting OSC2EN.

10.3.2.1 Internal Oscillator Trimming

OSCTRIM allows a clock period adjustment of +127 and -128 steps. Increasing the OSCTRIM value increases the clock period, which decreases the clock frequency. Trimming allows the internal clock frequency to be fine tuned to the target frequency.

All devices are factory programmed with a trim value that is stored in FLASH memory at location \$FFC0. This trim value is not automatically loaded into OSCTRIM register. User software must copy the trim value



Enhanced Serial Communications Interface (ESCI) Module

a valid character that sets the SCRF bit before an idle condition can set the IDLE bit. Also, after the IDLE bit has been cleared, a valid character must again set the SCRF bit before an idle condition can set the IDLE bit.

- 1 = Receiver input idle
- 0 = Receiver input active (or idle since the IDLE bit was cleared)

OR — Receiver Overrun Bit

This clearable, read-only bit is set when software fails to read the SCDR before the receive shift register receives the next character. The OR bit generates an ESCI error interrupt request if the ORIE bit in SCC3 is also set. The data in the shift register is lost, but the data already in the SCDR is not affected. Clear the OR bit by reading SCS1 with OR set and then reading the SCDR.

1 = Receive shift register full and SCRF = 1

0 = No receiver overrun

Software latency may allow an overrun to occur between reads of SCS1 and SCDR in the flag-clearing sequence. Figure 13-13 shows the normal flag-clearing sequence and an example of an overrun caused by a delayed flag-clearing sequence. The delayed read of SCDR does not clear the OR bit because OR was not set when SCS1 was read. Byte 2 caused the overrun and is lost. The next flag-clearing sequence reads byte 3 in the SCDR instead of byte 2.

In applications that are subject to software latency or in which it is important to know which byte is lost due to an overrun, the flag-clearing routine can check the OR bit in a second read of SCS1 after reading the data register.



Figure 13-13. Flag Clearing Sequence



Enhanced Serial Communications Interface (ESCI) Module

PDS[2:1:0]	PSSB[4:3:2:1:0]	SCP[1:0]	Prescaler Divisor (BPD)	SCR[2:1:0]	Baud Rate Divisor (BD)	Baud Rate (f _{Bus} = 4.9152 MHz)
000	ххххх	0 0	1	0 0 0	1	76,800
1 1 1	00000	0 0	1	000	1	9600
1 1 1	00001	0 0	1	000	1	9562.65
1 1 1	00010	0 0	1	000	1	9525.58
1 1 1	11111	0 0	1	000	1	8563.07
000	ххххх	0 0	1	001	2	38,400
000	ххххх	0 0	1	010	4	19,200
000	X X X X X	0 0	1	011	8	9600
000	ххххх	0 0	1	100	16	4800
000	ххххх	0 0	1	101	32	2400
000	ххххх	0 0	1	110	64	1200
000	ххххх	0 0	1	111	128	600
000	ххххх	0 1	3	000	1	25,600
000	X X X X X	0 1	3	001	2	12,800
000	ххххх	0 1	3	010	4	6400
000	ххххх	0 1	3	011	8	3200
000	ххххх	0 1	3	100	16	1600
000	X	0 1	3	101	32	800
000	ххххх	0 1	3	110	64	400
000	ххххх	0 1	3	111	128	200
000	ххххх	10	4	000	1	19,200
000	X	10	4	001	2	9600
000	ххххх	10	4	010	4	4800
000	ххххх	10	4	011	8	2400
000	ххххх	10	4	100	16	1200
000	ххххх	10	4	101	32	600
000	ххххх	10	4	110	64	300
000	X	10	4	111	128	150
000	ххххх	11	13	000	1	5908
000	ххххх	11	13	001	2	2954
000	X	11	13	010	4	1477
000	ххххх	11	13	011	8	739
000	X X X X X	11	13	100	16	369
000	X X X X X	11	13	101	32	185
000	X	11	13	110	64	92
0 0 0	XXXXX	1 1	13	111	128	46

Table 13-10. ESCI Baud Rate Selection Examples



Wait mode can also be exited by a reset (or break in emulation mode). A break interrupt during wait mode sets the SIM break stop/wait bit, SBSW, in the break status register (BSR). If the COP disable bit, COPD, in the configuration register is 0, then the computer operating properly module (COP) is enabled and remains active in wait mode.

Figure 14-15 and Figure 14-16 show the timing for wait recovery.



NOTE: EXITSTOPWAIT = RST pin OR CPU interrupt



Figure 14-16. Wait Recovery from Internal Reset

14.7.2 Stop Mode

In stop mode, the SIM counter is reset and the system clocks are disabled. An interrupt request from a module can cause an exit from stop mode. Stacking for interrupts begins after the selected stop recovery time has elapsed. Reset or break also causes an exit from stop mode.

The SIM disables the oscillator signals (BUSCLKX2 and BUSCLKX4) in stop mode, stopping the CPU and peripherals. If OSCENINSTOP is set, BUSCLKX4 will remain running in STOP and can be used to run the PWU. Stop recovery time is selectable using the SSREC bit in the configuration register 1 (CONFIG1). If SSREC is set, stop recovery is reduced from the normal delay of 4096 BUSCLKX4 cycles down to 32. This is ideal for the internal oscillator, RC oscillator, and external oscillator options which do not require long start-up times from stop mode.

NOTE External crystal applications should use the full stop recovery time by clearing the SSREC bit.



System Integration Module (SIM)

The SIM counter is held in reset from the execution of the STOP instruction until the beginning of stop recovery. It is then used to time the recovery period. Figure 14-17 shows stop mode entry timing and Figure 14-18 shows the stop mode recovery time from interrupt or break

NOTE To minimize stop current, all pins configured as inputs should be driven to



Figure 14-18. Stop Mode Recovery from Interrupt

14.8 SIM Registers

The SIM has three memory mapped registers. Table 14-4 shows the mapping of these registers.

Table	14-4.	SIM	Registers
-------	-------	-----	-----------

Address	Register	Access Mode
\$FE00	BSR	User
\$FE01	SRSR	User
\$FE03	BFCR	User



output after the TIM1 overflows. At each subsequent overflow, the TIM1 channel registers (0 or 1) that control the output are the ones written to last. T1SC0 controls and monitors the buffered output compare function, and TIM1 channel 1 status and control register (T1SC1) is unused. While the MS0B bit is set, the channel 1 pin, T1CH1, is available as a general-purpose I/O pin.

Channels 2 and 3 can be linked to form a buffered output compare channel whose output appears on the T1CH2 pin. The TIM1 channel registers of the linked pair alternately control the output.

Setting the MS2B bit in TIM1 channel 2 status and control register (T1SC2) links channel 2 and channel 3. The output compare value in the TIM1 channel 2 registers initially controls the output on the T1CH2 pin. Writing to the TIM1 channel 3 registers enables the TIM1 channel 3 registers to synchronously control the output after the TIM1 overflows. At each subsequent overflow, the TIM1 channel registers (2 or 3) that control the output are the ones written to last. T1SC2 controls and monitors the buffered output compare function, and TIM1 channel 3 status and control register (T1SC3) is unused. While the MS2B bit is set, the channel 3 pin, T1CH3, is available as a general-purpose I/O pin.

NOTE

In buffered output compare operation, do not write new output compare values to the currently active channel registers. User software should track the currently active channel to prevent writing a new value to the active channel. Writing to the active channel registers is the same as generating unbuffered output compares.

16.3.4 Pulse Width Modulation (PWM)

By using the toggle-on-overflow feature with an output compare channel, the TIM1 can generate a PWM signal. The value in the TIM1 counter modulo registers determines the period of the PWM signal. The channel pin toggles when the counter reaches the value in the TIM1 counter modulo registers. The time between overflows is the period of the PWM signal.

As Figure 16-3 shows, the output compare value in the TIM1 channel registers determines the pulse width of the PWM signal. The time between overflow and output compare is the pulse width. Program the TIM1 to clear the channel pin on output compare if the polarity of the PWM pulse is 1 (ELSxA = 0). Program the TIM1 to set the pin if the polarity of the PWM pulse is 0 (ELSxA = 1).



Figure 16-3. PWM Period and Pulse Width



Development Support

	Functions							
Modes	Reset Vector High	Reset Vector Low	Break Vector High	Break Vector Low	SWI Vector High	SWI Vector Low		
User	\$FFFE	\$FFFF	\$FFFC	\$FFFD	\$FFFC	\$FFFD		
Monitor	\$FEFE	\$FEFF	\$FEFC	\$FEFD	\$FEFC	\$FEFD		

Table 1	8-2.	Mode	Difference
---------	------	------	------------

18.3.1.4 Data Format

Communication with the monitor ROM is in standard non-return-to-zero (NRZ) mark/space data format. Transmit and receive baud rates must be identical.



Figure 18-13. Monitor Data Format

18.3.1.5 Break Signal

A start bit (logic 0) followed by nine logic 0 bits is a break signal. When the monitor receives a break signal, it drives the PTA0 pin high for the duration of two bits and then echoes back the break signal.



Figure 18-14. Break Transaction

18.3.1.6 Baud Rate

The monitor communication baud rate is controlled by the frequency of the external or internal oscillator and the state of the appropriate pins as shown in Table 18-1.

Table 18-1 also lists the bus frequencies to achieve standard baud rates. The effective baud rate is the bus frequency divided by 256 when using an external oscillator. When using the internal oscillator in forced monitor mode, the effective baud rate is the bus frequency divided by 335.

18.3.1.7 Commands

The monitor ROM firmware uses these commands:

- READ (read memory)
- WRITE (write memory)
- IREAD (indexed read)
- IWRITE (indexed write)
- READSP (read stack pointer)
- RUN (run user program)



Monitor Module (MON)

The monitor ROM firmware echoes each received byte back to the PTA0 pin for error checking. An 11-bit delay at the end of each command allows the host to send a break character to cancel the command. A delay of two bit times occurs before each echo and before READ, IREAD, or READSP data is returned. The data returned by a read command appears after the echo of the last byte of the command.



NOTE Wait one bit time after each echo before sending the next byte.





Figure 18-16. Write Transaction

A brief description of each monitor mode command is given in Table 18-3 through Table 18-8.



Table 18-3. READ (Read Memory) Command



Chapter 19 Electrical Specifications

19.1 Introduction

This section contains electrical and timing specifications.

19.2 Absolute Maximum Ratings

Maximum ratings are the extreme limits to which the microcontroller unit (MCU) can be exposed without permanently damaging it.

NOTE

This device is not guaranteed to operate properly at the maximum ratings. Refer to 19.5 5-V DC Electrical Characteristics and 19.8 3.3-V DC Electrical Characteristics for guaranteed operating conditions.

Characteristic ⁽¹⁾	Symbol	Value	Unit
Supply voltage	V _{DD}	-0.3 to +6.0	V
Input voltage	V _{IN}	V_{SS} –0.3 to V_{DD} +0.3	V
Mode entry voltage, IRQ pin	V _{TST}	V _{SS} –0.3 to +9.1	V
Maximum current per pin excluding PTA0–PTA5, V _{DD} , and V _{SS}	I	±15	mA
Maximum current for pins PTA0-PTA5	I _{PTA0} _I _{PTA5}	±25	mA
Storage temperature	T _{STG}	-55 to +150	°C
Maximum current out of V _{SS}	I _{MVSS}	100	mA
Maximum current into V _{DD}	I _{MVDD}	100	mA

1. Voltages references to V_{SS} .

NOTE

This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum-rated voltages to this high-impedance circuit. For proper operation, it is recommended that V_{IN} and V_{OUT} be constrained to the range $V_{SS} \leq (V_{IN} \text{ or } V_{OUT}) \leq V_{DD}$. Reliability of operation is enhanced if unused inputs are connected to an appropriate logic voltage level (for example, either V_{SS} or V_{DD} .)





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NOTES:

1. CONTROLLING DIMENSION: MILLIMETER

2. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M-1982.

3 DIMENSION DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE.

 $\frac{4}{4}$ dimension does not include interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.25 per side.

5 DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 TOTAL IN EXCESS OF THE DIMENSION AT MAXIMUM MATERIAL CONDITION.

6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY

7 \setminus dimensions are to be determined at datum plane [-w-

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